


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541245	<b>Applicant(s)/Patent Under Reexamination</b>  KUSUBAYASHI, CHIYO
	<b>Examiner</b>  Hal I Kaplan	<b>Art Unit</b>  2836

SEARCHED			
Class	Subclass	Date	Examiner
307	9.1	4/1/2008	HK
307	26	4/1/2008	HK
307	28	4/1/2008	HK
307	29	4/1/2008	HK
307	45	4/1/2008	HK
307	75	4/1/2008	HK
307	83	4/1/2008	HK
307	145	4/1/2008	HK
191	2	4/1/2008	HK
191	4	4/1/2008	HK
191	8	4/1/2008	HK
191	23A	4/1/2008	HK
363	51	4/1/2008	HK
180	65.1	4/1/2008	HK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	4/1/2008	HK

INTERFERENCE SEARCH			
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